DEC 1 3 2004

Docket No.: 50090-332

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Customer Number: 20277

Hisaya MORI, et al.

Confirmation Number: 4507

Application No.: 09/927,368

Group Art Unit: 2829

Filed: August 13, 2001

Examiner: J. M. Hollington

For: APPARATUS AND METHOD FOR TESTING SEMICONDUCTOR INTEGRATED

**CIRCUIT** 

## **PETITION FOR EXTENSION OF TIME**

Mail Stop AF Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

It is respectfully requested that the time for response to the Office Action dated August 12, 2004, now due to expire November 12, 2004, be extended for one month(s) and set to expire on December 12, 2004.

Please charge the extension fee of \$120.00 to Deposit Account No. 500417. Please charge any additional fees or credit any overpayment to Deposit Account No. 500417.

Respectfully submitted,

12/14/2004 CNGUYEN 00000047 500417 09927368

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McDERMOTT WILL & EMERY LLP

Alexander V. Yampolsky Registration No. 36,324

600 13<sup>th</sup> Street, N.W. Washington, DC 20005-3096

Phone: 202.756.8000 SAB/AVY/dlb

Facsimile: 202.756.8087

Date: December 13, 2004

Please recognize our Customer No. 20277 as our correspondence address.